

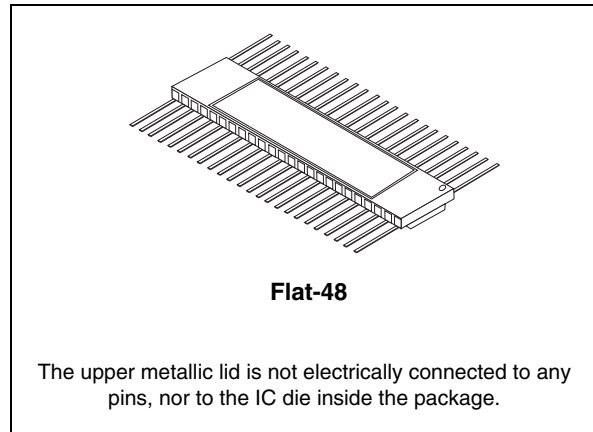


54VCXH162373

Rad hard low voltage CMOS 16-bit D-type latch (3-state)
with 3.6 V tolerant inputs and outputs

Features

- 1.65 to 3.6 V inputs and outputs
- High speed:
 - $t_{PD} = 3.3$ ns (Max.) at $V_{CC} = 3.0$ to 3.6 V
 - $t_{PD} = 4.5$ ns (Max.) at $V_{CC} = 2.3$ to 2.7 V
- Symmetrical impedance outputs:
 - $|I_{OH}| = I_{OL} = 12$ mA (Min.) at $V_{CC} = 3.0$ V
 - $|I_{OH}| = I_{OL} = 8$ mA (Min.) at $V_{CC} = 2.3$ V
- Power down protection on inputs and outputs
- 26 Ω serie resistors in outputs
- Operating voltage range:
 - $V_{CC(Opr)} = 1.65$ V to 3.6 V
- Pin and function compatible with 54 series HR162373
- Bus hold provided on both sides
- Cold spare function
- Latch-up performance exceeds 300 mA (JESD 17)
- ESD performance:
 - HBM > 2000 V (MIL STD 883 method 3015); MM > 200 V
- 300 krad Mil1019.6 condition A, (RHA QML qualification extension undergone)
- No SEL, no SEU and no SET under 110 Mev/cm²/mg LET heavy ions irradiation
- QML qualified product
- Device fully compliant with DSCC SMD 5962-05211
- 100 mV typical input hysteresis



Description

The 54VCXH162373 is a low voltage CMOS 16 bit d-type latch with 3 state outputs non inverting fabricated with sub-micron silicon gate and five-layer metal wiring C²MOS technology. It is ideal for low power and very high speed 1.65 to 3.6 V applications; it can be interfaced to 3.6 V signal environment for both inputs and outputs. These 16 bit D-type latches are bite controlled by two latch enable inputs (nLE) and two output enable inputs (\overline{OE}). While the nLE input is held at a high level, the nQ outputs will follow the data input precisely. When the nLE is taken low, the nQ outputs will be in a normal logic state (high or low logic level) and while high level the outputs will be in a high impedance state. Bus hold on data inputs is provided in order to eliminate the need for external pull-up or pull-down resistor. The device circuits is including 26 Ω series resistance in the outputs. These resistors permit to reduce line noise in high speed applications. All inputs and outputs are equipped with protection circuits against static discharge, giving them 2 kV ESD immunity and transient excess voltage.

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1 Logic symbols and I/O equivalent circuit

Figure 1. IEC logic symbols

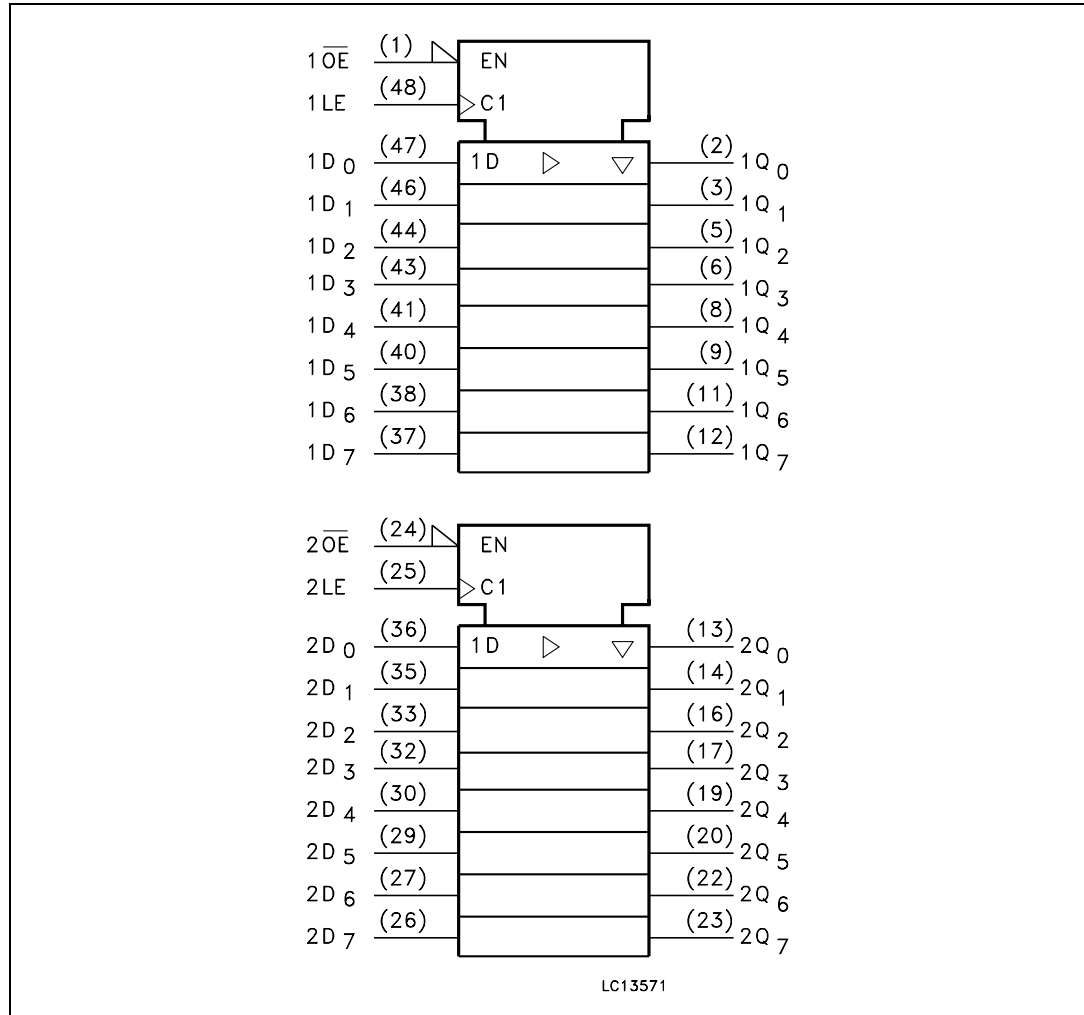


Figure 2. Input and output equivalent circuit

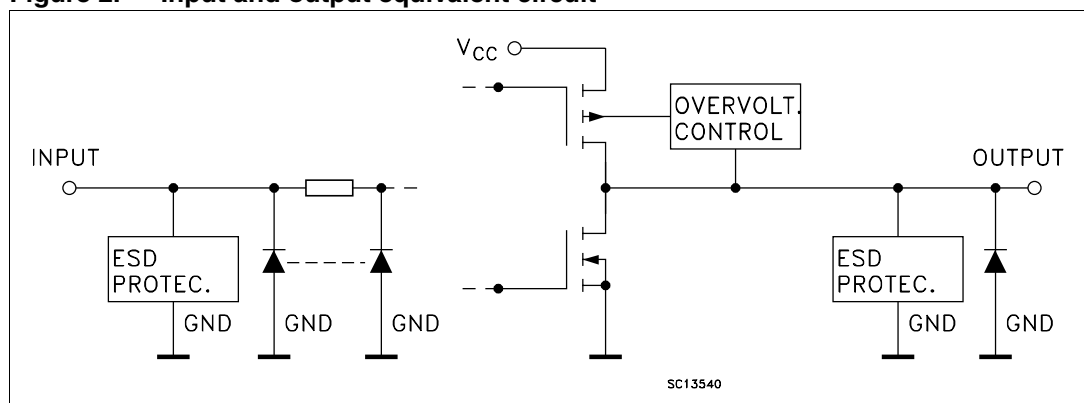
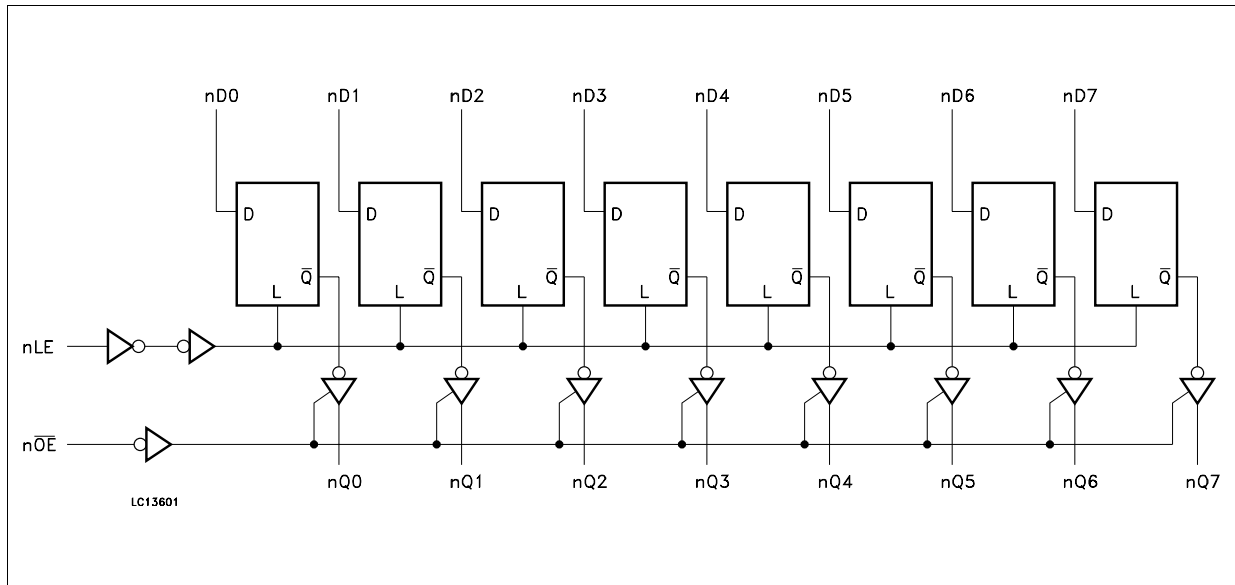


Figure 3. Logic diagram

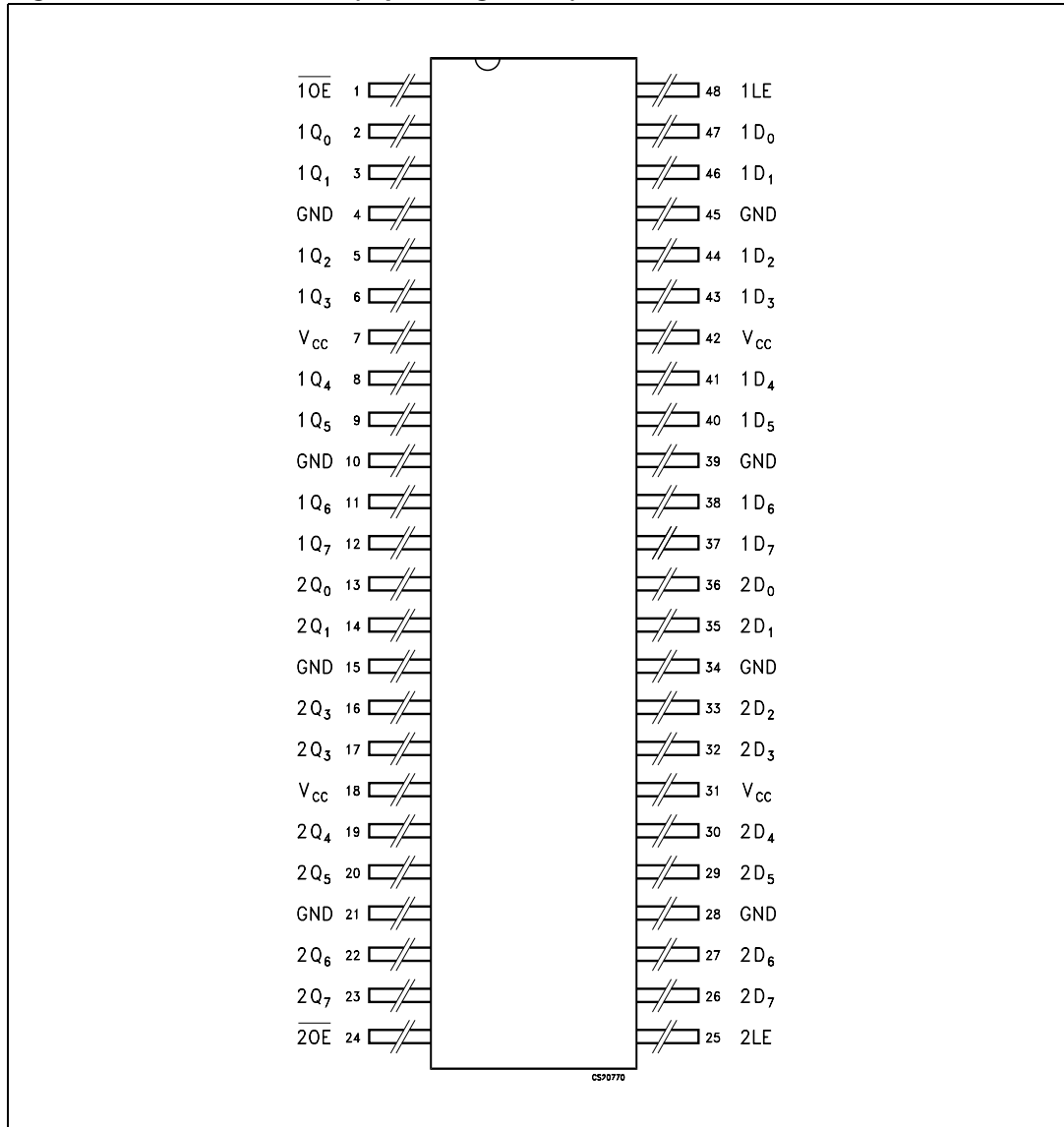


Note: This logic diagram has not to be used to estimate propagation delays

2 Pin settings

2.1 Pin connection

Figure 4. Pin connection (top through view)



2.2 Pin description

Table 1. Pin description

Pin n°	Symbol	Name and function
1	$\overline{1OE}$	3 state output enable input (active LOW)
2, 3, 5, 6, 8, 9, 11, 12	1Q0 to 1Q7	3-state outputs
13, 14, 16, 17, 19, 20, 22, 23	2Q0 to 2Q7	3-state outputs
24	$\overline{2OE}$	3 state output enable input (active LOW)
25	2LE	Latch enable input
36, 35, 33, 32, 30, 29, 27, 26	2D0 to 2D7	Data inputs
47, 46, 44, 43, 41, 40, 38, 37	1D0 to 1D7	Data inputs
48	1LE	Latch enable input
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0 V)
7, 18, 31, 42	V _{CC}	Positive supply voltage

2.3 Truth table

Table 2. Truth table

Inputs			Output
OE	LE	D	Q
H	X	X	Z
L	L	X	No change ⁽¹⁾
L	H	L	L
L	H	H	H

1. Q outputs are latched at the time when the LE input is taken low logic level.

Note: X = Do not care; Z = High impedance

3 Maximum rating

Stressing the device above the rating listed in the “absolute maximum ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 3. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	Supply voltage	-0.5 to +4.6	V
V_I	DC input voltage	-0.5 to +4.6	V
V_O	DC output voltage (OFF state)	-0.5 to +4.6	V
V_O	DC output voltage (High or low state) ⁽¹⁾	-0.5 to $V_{CC} + 0.5$	V
I_{IK}	DC input diode current	- 50	mA
I_{OK}	DC output diode current ⁽²⁾	- 50	mA
I_O	DC output current	± 50	mA
I_{CC} or I_{GND}	DC V_{CC} or ground current per supply pin	± 100	mA
P_D	Power dissipation	400	mW
T_{stg}	Storage temperature	-65 to +150	°C
T_L	Lead temperature (10 sec)	260	°C

1. I_O absolute maximum rating must be observed

2. $V_O < GND$, $V_O > V_{CC}$

3.1 Recommended operating conditions

Table 4. Recommended operating conditions

Symbol	Parameter	Value	Unit
V_{CC}	Supply voltage	1.8 to 3.6	V
V_I	Input voltage	-0.3 to 3.6	V
V_O	Output voltage (OFF state)	0 to 3.6	V
V_O	Output voltage (high or low state)	0 to V_{CC}	V
I_{OH} , I_{OL}	High or low level output current ($V_{CC} = 3.0$ to 3.6 V)	± 12	mA
I_{OH} , I_{OL}	High or low level output current ($V_{CC} = 2.3$ to 2.7 V)	± 8	mA
T_{op}	Operating temperature	-55 to 125	°C
dt/dv	Input rise and fall time ⁽¹⁾	0 to 10	ns/V

1. V_{IN} from 0.8 V to 2 V at $V_{CC} = 3.0$ V

4 Electrical characteristics

2.7 V < V_{CC} < 3.6 V unless otherwise specified

Table 5. DC specifications

Symbol	Parameter	Test condition		Value		Unit
		V _{CC} (V)		-55 to 125°C		
				Min.	Max.	
V _{IH}	High level input voltage	2.7 to 3.6		2.0		V
V _{IL}	Low level input voltage				0.8	
V _{OH}	High level output voltage	2.7 to 3.6	I _O =-100 μA	V _{CC} -0.2		V
		2.7	I _O =-6 mA	2.2		
		3.0	I _O =-8 mA	2.4		
			I _O =-12 mA	2.2		
V _{OL}	Low level output voltage	2.7 to 3.6	I _O =100 μA		0.2	V
		2.7	I _O =6 mA		0.4	
		3.0	I _O =8 mA		0.55	
			I _O =12 mA		0.8	
I _I	Input leakage current	2.7 to 3.6	V _I = 0 to 3.6 V		± 5	μA
I _{I(HOLD)}	Input hold current	3.0	V _I = 0.8 V	75		μA
			V _I = 2 V	-75		
		3.6	V _I = 0 to 3.6 V		± 500	
I _{off}	Power Off leakage current	0	V _I or V _O = 0 to 3.6 V		10	μA
I _{OZ}	High impedance output leakage current	2.7 to 3.6	V _I = V _{IH} or V _{IL} V _O = 0 to 3.6 V		± 10	μA
I _{CC}	Quiescent supply current	2.7 to 3.6	V _I = V _{CC} or GND		20	μA
			V _I or V _O = V _{CC} to 3.6 V		± 20	
ΔI _{CC}	I _{CC} incr. per Input	2.7 to 3.6	V _{IH} = V _{CC} - 0.6 V		750	μA

2.3 V < V_{CC} < 2.7 V unless otherwise specified

Table 6. DC specifications

Symbol	Parameter	Test condition		Value			Unit
		V _{CC} (V)		-55 to 125 °C			
				Min.	Max.		
V _{IH}	High level input voltage	2.3 to 2.7		1.6		V	
V _{IL}	Low level input voltage				0.7		
V _{OH}	High level output voltage	2.3 to 2.7	I _O = -100 μA	V _{CC} -0.2		V	
		2.3	I _O = -4 mA	2.0			
			I _O = -6 mA	1.8			
			I _O = -8 mA	1.7			
V _{OL}	Low level output voltage	2.3 to 2.7	I _O = 100 μA		0.2	V	
		2.3	I _O = 6 mA		0.4		
			I _O = 8 mA		0.6		
I _I	Input leakage current	2.3 to 2.7	V _I = V _{CC} or GND		± 5	μA	
I _{I(HOLD)}	Input hold current	2.3	V _I = 0.7 V	45		μA	
			V _I = 1.7 V	-45			
I _{off}	Power Off leakage current	0	V _I or V _O = 0 to 3.6 V		10	μA	
I _{OZ}	High impedance output leakage current	2.3 to 2.7	V _I = V _{IH} or V _{IL} V _O = 0 to 3.6 V		± 10	μA	
I _{CC}	Quiescent supply current	2.3 to 2.7	V _I = V _{CC} or GND		20	μA	
			V _I or V _O = V _{CC} to 3.6 V		± 20		

T_A = 25 °C, Input t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω

Table 7. Dynamic switching characteristics

Symbol	Parameter	Test condition		Value			Unit
		V _{CC} (V)		T _A = 25 °C			
				Min.	Typ.	Max.	
V _{OLV}	Dynamic valley low voltage quiet output ⁽¹⁾ ⁽²⁾	2.5	V _{IL} = 0 V	-	0.25	-	V
		3.3	V _{IH} = V _{CC}	-	0.35	-	
V _{OHV}	Dynamic valley high voltage quiet output ⁽²⁾ ⁽³⁾	2.5	V _{IL} = 0 V	-	-0.25	-	V
		3.3	V _{IH} = V _{CC}	-	-0.35	-	
V _{OHV}	Dynamic valley high voltage quiet output ⁽²⁾ ⁽³⁾	2.5	V _{IL} = 0 V	-	2.05	-	V
		3.3	V _{IH} = V _{CC}	-	2.65	-	

- Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH to LOW or LOW to HIGH. The remaining output is measured in the LOW state.
- Parameters guaranteed by design.
- Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH to LOW or LOW to HIGH. The remaining output is measured in the HIGH state.

$C_L = 30 \text{ pF}$, $R_L = 500 \text{ } \Omega$, Input $t_r = t_f = 2.0 \text{ ns}$

Table 8. AC electrical characteristics

Symbol	Parameter	Test condition		Value		Unit
		V_{CC} (V)		-55 to 125 °C		
				Min.	Max.	
t_{PLH} t_{PHL}	Propagation delay time Dn to Qn	2.3 to 2.7		1.0	5.2	ns
		3.0 to 3.6		0.8	4.0	
t_{PLH} t_{PHL}	Propagation delay time LE to Qn	2.3 to 2.7		1.0	5.7	ns
		3.0 to 3.6		0.8	4.2	
t_{PZL} t_{PZH}	Output enable time	2.3 to 2.7		1.0	6.2	ns
		3.0 to 3.6		0.8	4.7	
t_{PLZ} t_{PHZ}	Output disable time	2.3 to 2.7		1.0	5.1	ns
		3.0 to 3.6		0.8	4.8	
t_s	Setup time, HIGH or LOW level Dn to LE	2.3 to 2.7		1.0		ns
		3.0 to 3.6		1.0		
t_h	Hold time HIGH or LOW level Dn to LE	2.3 to 2.7		1.5		ns
		3.0 to 3.6		1.5		
t_w	LE pulse width, HIGH	2.3 to 2.7		1.5		ns
		3.0 to 3.6		1.5		
t_{OSLH} t_{OSHL}	Output to output skew time ⁽¹⁾ ⁽²⁾	2.3 to 2.7			0.5	ns
		3.0 to 3.6			0.5	

- Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW ($t_{OSLH} = |t_{PLHm} - t_{PLHn}|$, $t_{OSHL} = |t_{PHLm} - t_{PHLn}|$)
- Parameter guaranteed by design

Table 9. Capacitive characteristics

Symbol	Parameter	Test condition		Value			Unit
		V_{CC} (V)		T _A = 25 °C			
				Min.	Typ.	Max.	
C_{IN}	Input capacitance	2.5 or 3.3	$V_{IN} = 0$ or V_{CC}	-	6	-	pF
C_{OUT}	Output capacitance	2.5 or 3.3	$V_{IN} = 0$ or V_{CC}	-	7	-	pF
C_{PD}	Power dissipation capacitance ⁽¹⁾	2.5 or 3.3	$f_{IN} = 10\text{MHz}$ $V_{IN} = 0$ or V_{CC}	-	20	-	pF

- C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation. $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/16$ (per circuit)

5 Test circuit

Figure 5. Test circuit

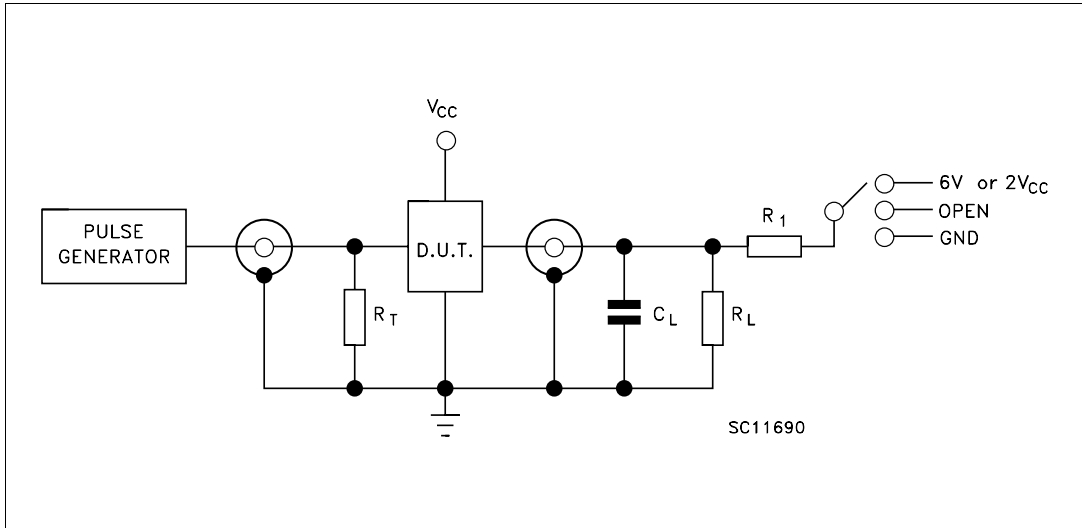


Table 10. Test circuit

Test	Switch
t_{PLH} , t_{PHL}	Open
t_{PZL} , t_{PLZ} ($V_{CC} = 3.0$ to 3.6 V)	6 V
t_{PZL} , t_{PLZ} ($V_{CC} = 2.3$ to 2.7 V)	$2 V_{CC}$
t_{PZH} , t_{PHZ}	GND

$C_L = 30$ pF or equivalent (includes jig and probe capacitance)

$R_L = R_1 = 500 \Omega$ or equivalent

$R_T = Z_{OUT}$ of pulse generator (typically 50Ω)

6 Waveforms

Table 11. Waveform symbol value

Symbol	V _{CC}	
	3.0 to 3.6 V	2.3 to 2.7 V
V _{IH}	2.7 V	V _{CC}
V _M	1.5 V	V _{CC} /2
V _X	V _{OL} + 0.3 V	V _{OL} + 0.15 V
V _Y	V _{OH} - 0.3 V	V _{OH} - 0.15 V

Figure 6. Waveform - LE TO Qn propagation delays, LE minimum pulse width, Dn to LE setup and hold times (f = 1 MHz; 50% duty cycle)

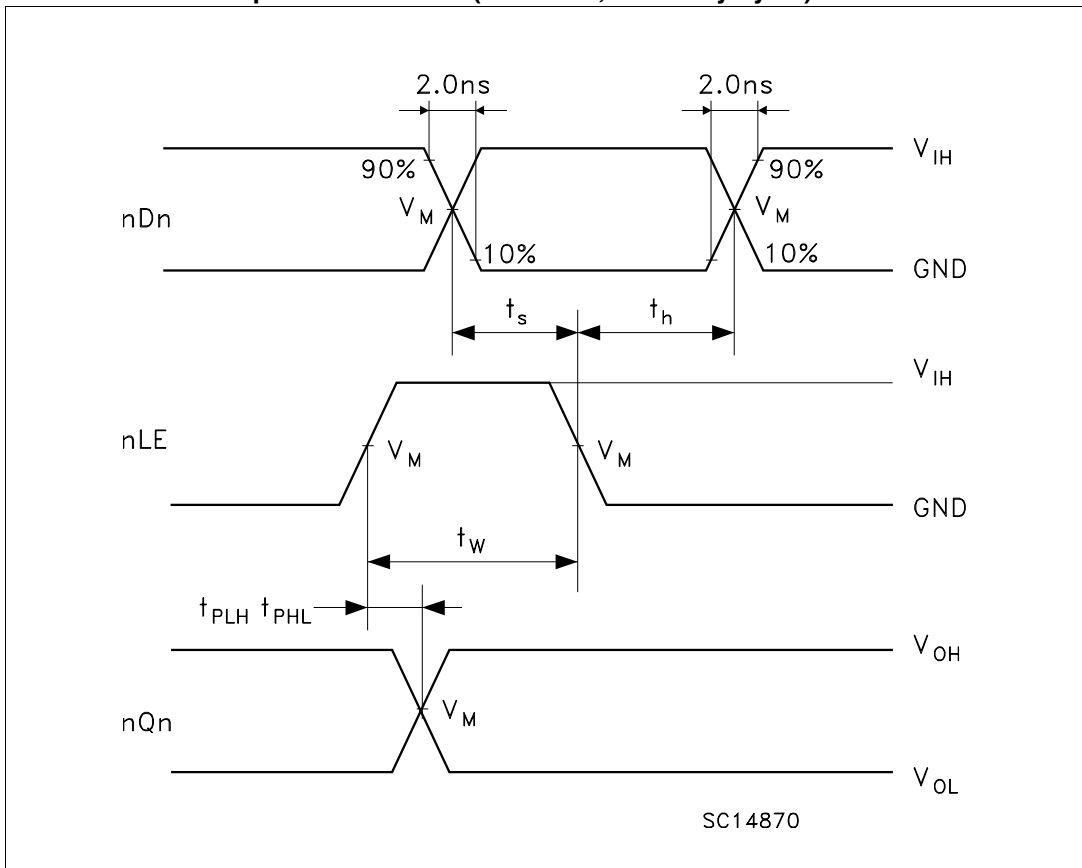


Figure 7. Waveform - output enable and disable time (f = 1 MHz; 50% duty cycle)

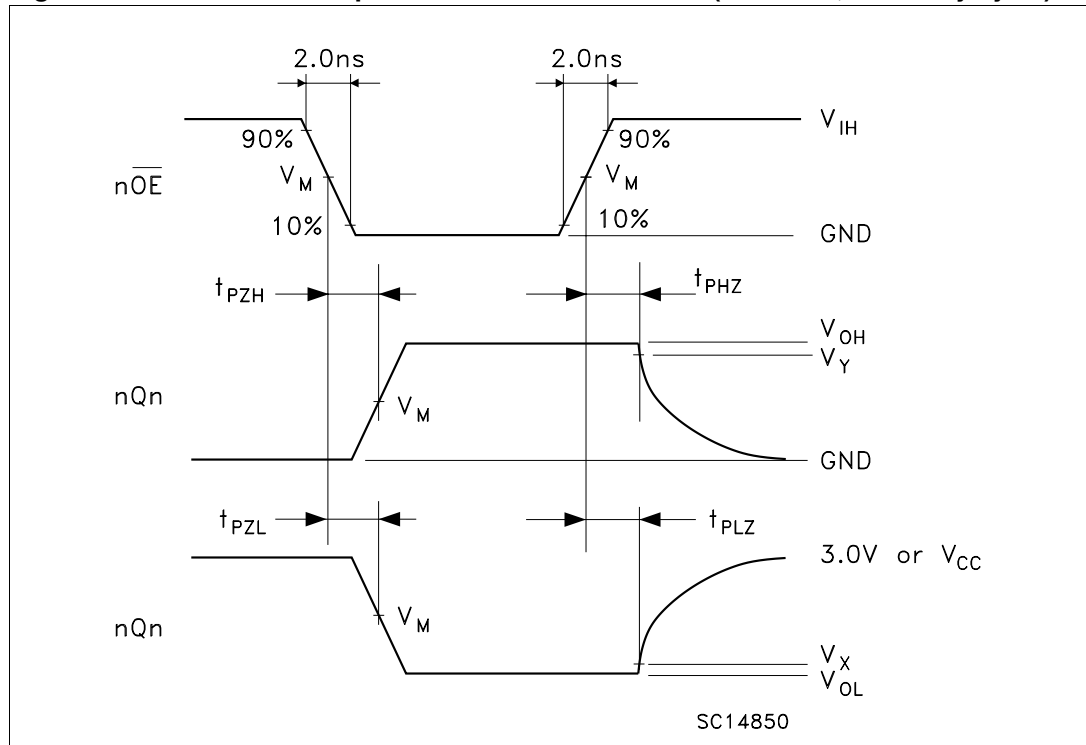
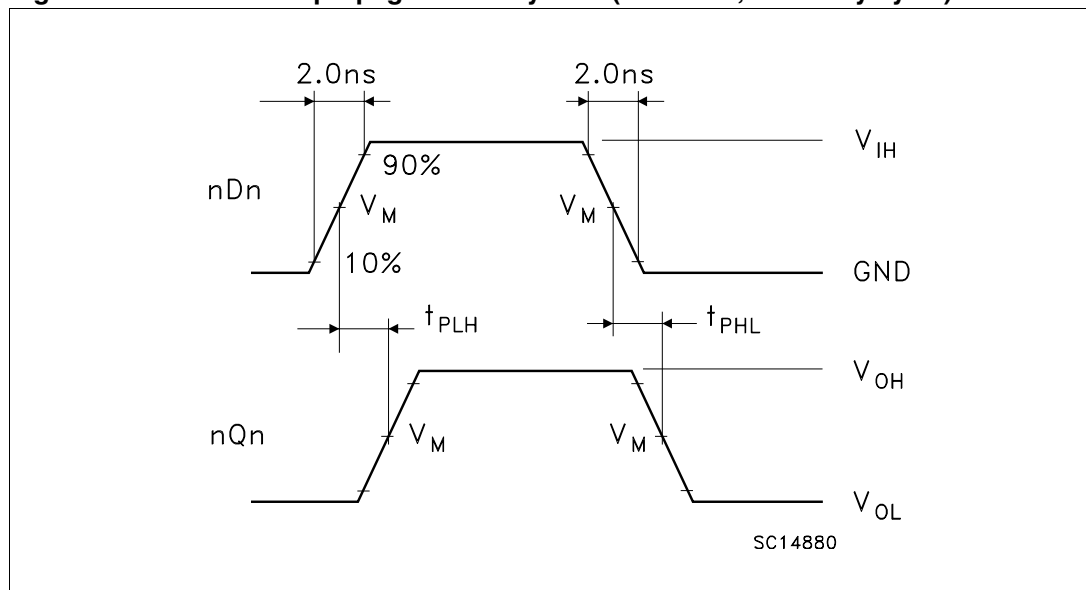


Figure 8. Waveform - propagation delay time (f = 1 MHz; 50% duty cycle)



7 Package mechanical data

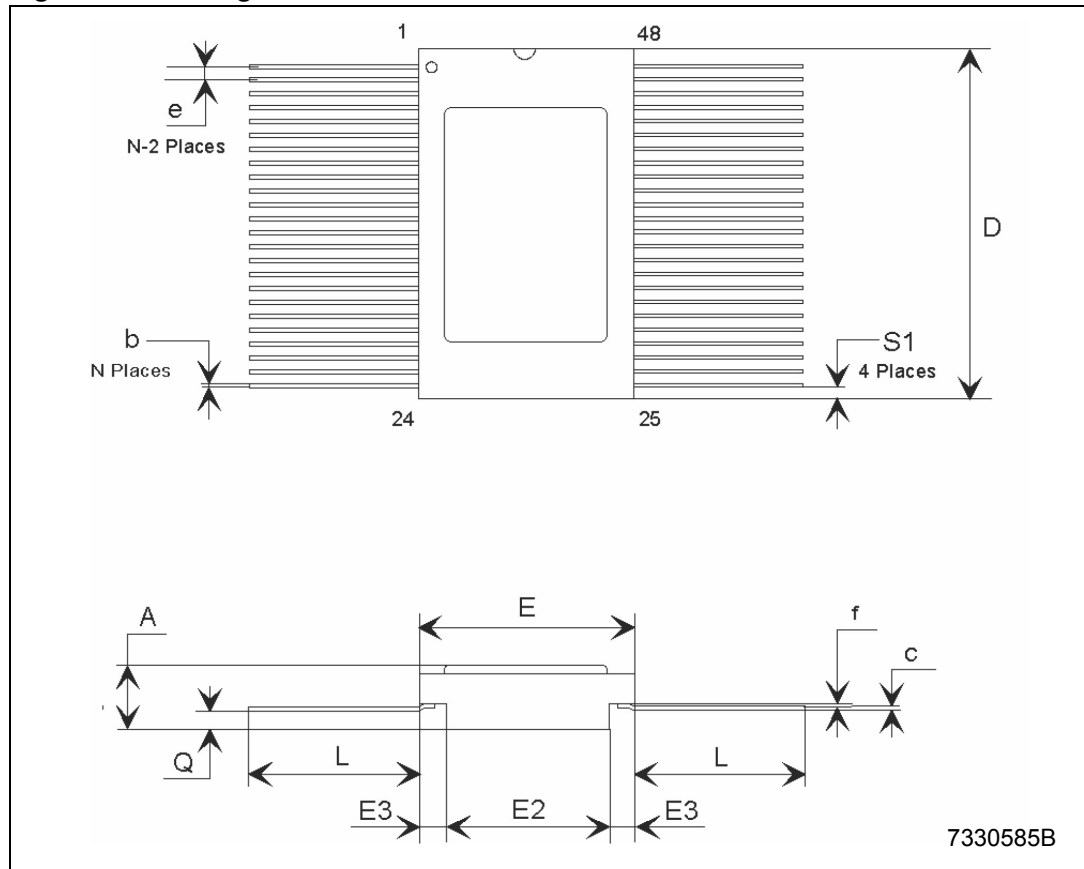
54VCXH162373 products are supplied into ceramic body / metal lid hermetic Flat 48-pin space package

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Table 12. Flat-48 (MIL-STD-1835) mechanical data

Dim.	mm			inch		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.18	2.47	2.72	0.086	0.097	0.107
b	0.20	0.254	0.30	0.008	0.010	0.012
c	0.12	0.15	0.18	0.005	0.006	0.007
D	15.57	15.75	15.92	0.613	0.620	0.627
E	9.52	9.65	9.78	0.375	0.380	0.385
E2	6.22	6.35	6.48	0.245	0.250	0.255
E3	1.52	1.65	1.78	0.060	0.065	0.070
e		0.635			0.025	
f		0.20			0.008	
L	6.85	8.38	9.40	0.270	0.330	0.370
Q	0.66	0.79	0.92	0.026	0.031	0.036
S1	0.25	0.43	0.61	0.010	0.017	0.024

Figure 9. Package dimension



7330585B

Note: *The upper metallic lid is not electrically connected to any pins, nor to the IC die inside the package. Connecting unused pins or metal lid to ground or to the power supply will not affect the electrical characteristics.*

8 Order codes

Table 13. Ordering information

Package	Min op. voltage	Lead finish	Radiation level	Flight models	Engineering model	Packing
				QML-V		
48-pin flat	1.8 V	Gold plated	300 krad	RHFXH162373K03V	RHRXH162373K1	Conductive strip pack

9 Revision history

Table 14. Document revision history

Date	Revision	Changes
09-Jul-2004	1	First release
17-May-2005	2	SMD qualified
19-Jun-2006	3	300 krad bullet updated, new template, mechanical data updated
30-Jul-2007	4	Typo in Table 12 on page 14 .
17-Sep-2008	5	Updated cover page
23-Sep-2009	6	Updated Table 13 on page 16
02-Aug-2011	7	Added Note: on page 15 and in the "Pin connections" diagram on the coverpage

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